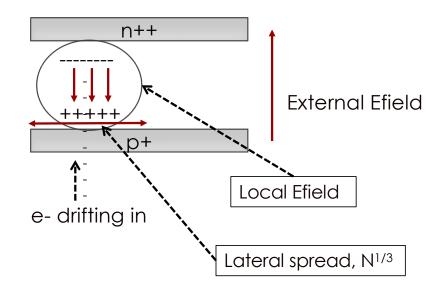
## Charge screening

The External Efield in the gain layer is due to Bias+Doping

When there are charges in the gain implant, on average, the electrons are one side while the holes are on the opposite side.

This imbalance creates a local Efield that is opposite to the external Efield.



The field is proportional to the density of charge.

N = number of charges  $N^{1/3} =$  lateral spread of the charge cloud

Density of charge: N/  $N^{1/3} = N^{2/3}$ 

$$\sigma = rac{Q}{A}$$
  $E_{local} = rac{\sigma}{arepsilon}$